

2SA1928

DUAL TRANSISTOR
FOR LOW NOISE DIFFERENTIAL AMPLIFY APPLICATION
SILICON PNP EPITAXIAL TYPE

DESCRIPTION

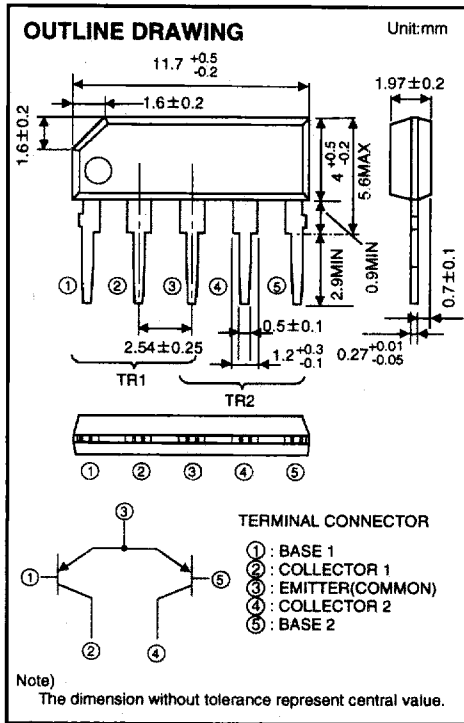
Mitsubishi 2SA1928 is a silicon PNP epitaxial type transistor. It is designed for low noise differential amplify application.

FEATURE

- High V_{CEO} $V_{CEO} = -100V$
- Low noise $NF = 0.5dB$ typ $NV = 100mV$ typ
- High h_{FE} $h_{FE} = 250$ to 800
- Good two elements characteristics
 $h_{FE1}/h_{FE2} = 0.98$ typ
 $|V_{BE1} - V_{BE2}| = 1mV$ typ

APPLICATION

For Low noise differential amplify application.



MAXIMUM RATINGS (Ta=25°C)

Symbol	Parameter	Rating	Unit
V_{CBO}	Collector to Base voltage	-100	V
V_{EBO}	Emitter to Base voltage	-5	V
V_{CEO}	Collector to Emitter voltage	-100	V
I_C	Collector current	-50	mA
P_C	Collector dissipation (Ta=25°C)	200	mW/unit
P_T	Total dissipation (Ta=25°C)	400	mW
T_j	Junction temperature	+125	°C
T_{stg}	Storage temperature	-55 to +125	°C

ELECTRICAL CHARACTERISTICS (Ta=25°C)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
$V_{(BR)CEO}$	C to E break down voltage	$I_C = -100 \mu A, R_{BE} = \infty$	-100			V
I_{CBO}	Collector cut off current	$V_{CB} = -70V, I_E = 0$			-0.1	μA
I_{EBO}	Emitter cut off current	$V_{EB} = -2V, I_C = 0$			-0.1	μA
I_{CER}	Collector cut off current	$V_{CE} = -100V, R_{BE} = 100k \Omega$			-10	μA
$h_{FE} *$	DC forward current gain	$V_{CE} = -6V, I_C = -1mA$	250		800	—
$V_{CE(sat)}$	C to E saturation voltage	$I_C = -10mA, I_B = -1mA$			-0.6	V
$ V_{BE1} - V_{BE2} $	B-E voltage differential	$V_{CE} = -6V, I_C = -1mA$		1	10	mV
h_{FE1}/h_{FE2}	DC forward current gain ratio	$V_{CE} = -6V, I_C = -1mA$	0.8	0.98	1.0	—
f_T	Gain band width product	$V_{CE} = -6V, I_E = 1mA$		150		MHz
C_{ob}	Collector output capacitance	$V_{CB} = -6V, I_E = 0, f = 1MHz$		2.5		pF
NF	Noise figure	$V_{CE} = -6V, I_E = 0.1mA, f = 1kHz, R_G = 10k \Omega$		0.5		dB
NV	Low frequency broadband noise voltage	effective value peaked value	$V_{CE} = -10V, I_E = 1mA, R_G = 100k \Omega, G_V = 80dB$ (Refer to test circuit)	100		mV
NVM				0.5		V

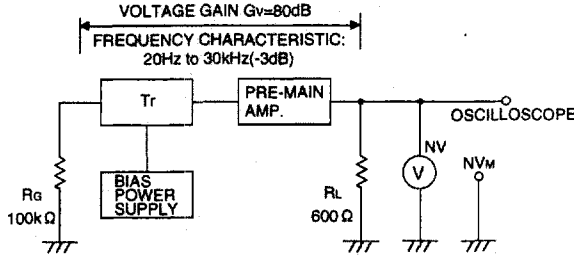
* : It shows h_{FE} (element 1) classification in right table.

Item	F	G
h_{FE}	250 to 500	400 to 800

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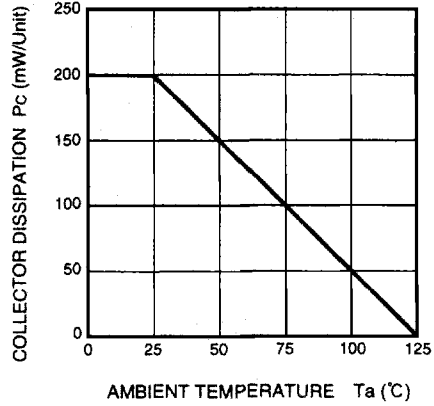
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LOW FREQUENCY WIDE BAND NOISE VOLTAGE TEST CIRCUIT

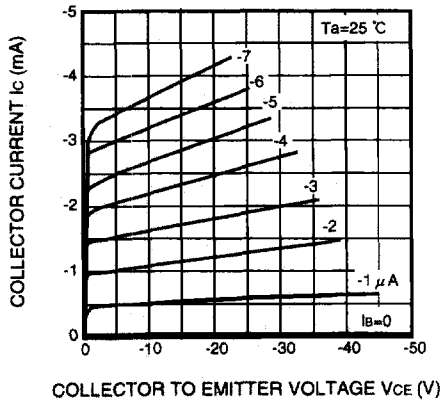


TYPICAL CHARACTERISTICS

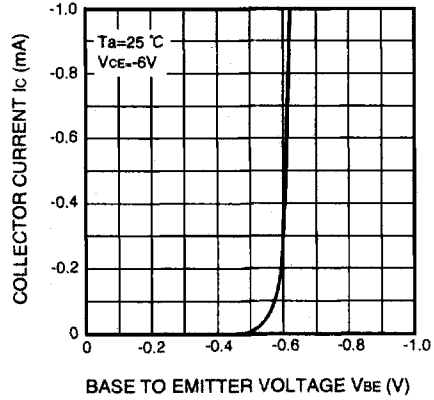
COLLECTOR DISSIPATION VS. AMBIENT TEMPERATURE



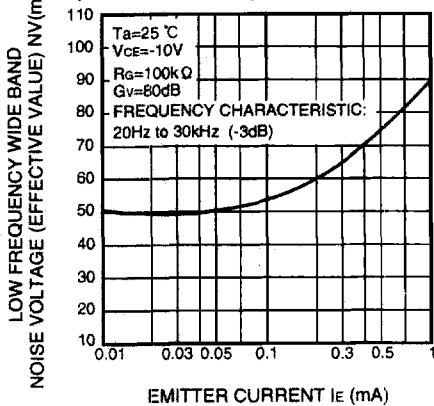
COMMON EMITTER OUTPUT



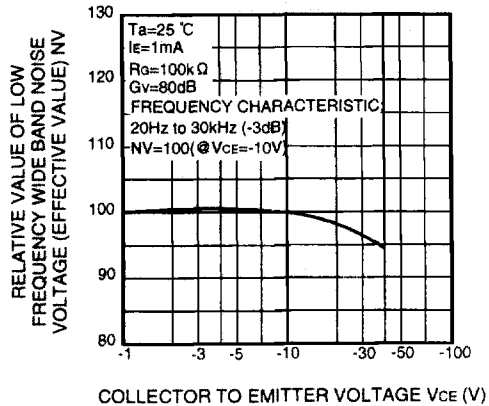
COMMON EMITTER TRANSFER



LOW FREQUENCY WIDE BAND NOISE VOLTAGE (EFFECTIVE VALUE) VS. EMITTER CURRENT

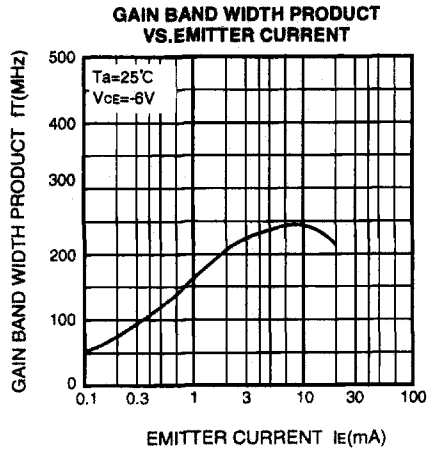
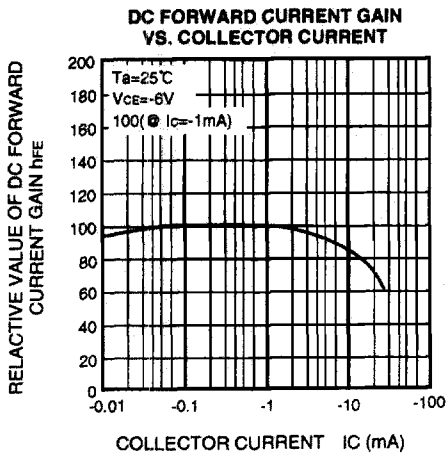
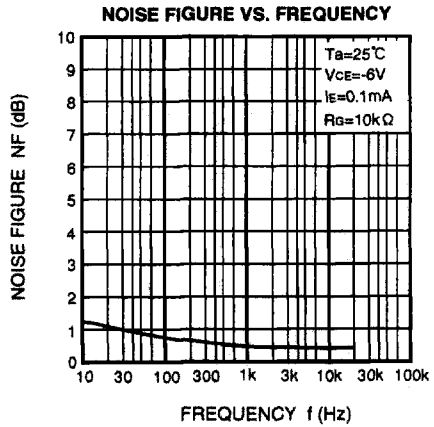
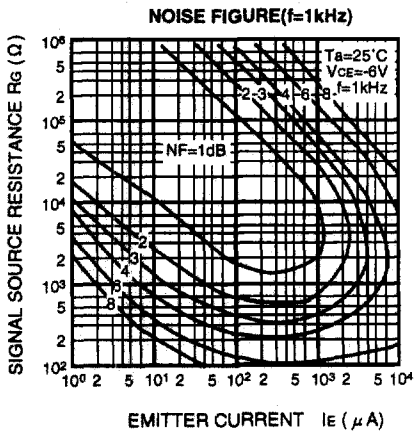
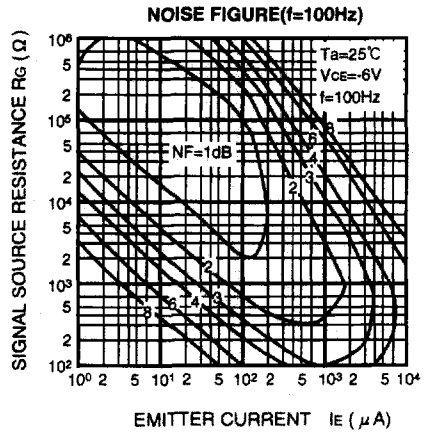
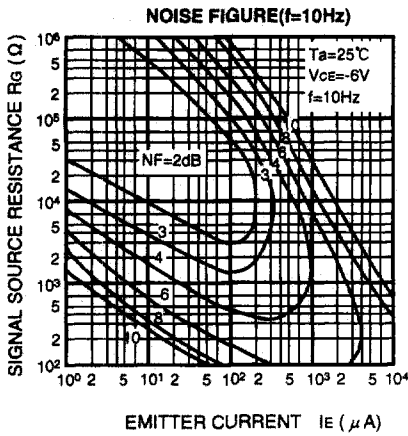


LOW FREQUENCY WIDE BAND NOISE VOLTAGE (EFFECTIVE VALUE) VS. COLLECTOR TO EMITTER VOLTAGE



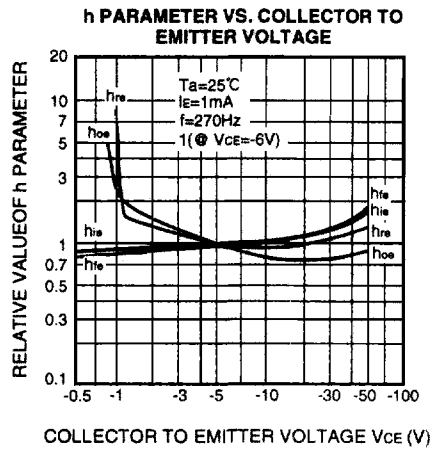
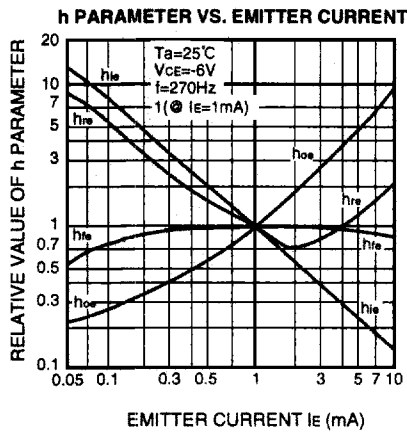
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COMMON EMITTER h PARAMETER (TYPICAL VALUE)

Symbol	Parameter	Test conditions	Limits	Unit
h_{ie}	Closed loop small signal input impedance	$T_a=25^\circ\text{C}$	14	$\text{k}\Omega$
h_{re}	Open loop small signal reverse voltage amplification factor	$V_{CE}=-6\text{V}$	0.08	$\times 10^{-3}$
h_{fe}	Closed loop small signal forward current amplification factor	$I_E=1\text{mA}$	500	—
h_{oe}	Open loop small signal output admittance	$f=270\text{Hz}$	19	μS